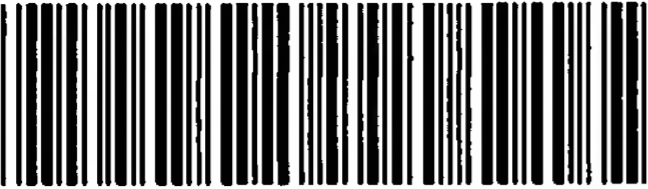


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/038,506	HOOVEN, MICHAEL D.	
	Examiner	Art Unit	
	Victoria W. Chen	3739	

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606	41, 48-52	8/15/2007	VWC
606	205,207	8/15/2007	VWC
607	98-99	8/15/2007	VWC

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
east search	8/15/2007	VWC